

Notice of References Cited	Application/Control No. 10/042,010	Applicant(s)/Patent Under Reexamination JAKUBEK ET AL.	
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	B	US-5,278,010	01-1994	Day et al.	430/18
	C	US-6,528,218 b1	03-2003	Foster et al.	430/14
	D	US-4,684,420	08-1987	Bryant et al.	156/116
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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	product Bulletin Epon TM RESin 1009F, Resolution Performance Products, RP:3066-01, 4 pages, copyright 2001 and 04/02 date on last page.
	V	Dupont Electronic Technologies, "THPE-GE-Toxicology summary", 2 pages, no date.
	W	RN 66072-38-6, Registry, ACS on STN, copyright 2003 one page
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	V	"Fatigue Life" from "Glossary of Materials Testing Terms", Intron at www.instron.com, 4 pages, copyright 2003.
	W	"Flex Life" from "Fisk Alloy Conductor Facts --Flex life at www.fiskalloy.com/c-fact-pages/c-flexlife, 2 pages, no date printed August 6, 2003.
	X	MIL-P-50884C dated April 9, 1993, retrieved from the Internet, "Military Specification; Printed-Wiring, Flexible and Rigid-Flex, 5 pages.

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